PI74FCT827T, PI74FCT828T
(25Ω Series) PI74FCT2827T
(25Ω Series) PI74FCT2828T

Fast CMOS
10-Bit Buffers

Product Features

- PI74FCT827/828/2827/2828T are pin compatible with bipolar FAST™ Series at a higher speed and lower power consumption
- 25Ω series resistor on all outputs (FCT2XXX only)
- TTL input and output levels
- Low ground bounce outputs
- Extremely low static power
- Hysteresis on all inputs
- Industrial operating temperature range: –40°C to +85°C
- Packages available:
  – 24-pin 300-mil wide plastic DIP (P)
  – 24-pin 150-mil wide plastic QSOP (Q)
  – 24-pin 150-mil wide plastic TQSOP (R)
  – 24-pin 300-mil wide plastic SOIC (S)

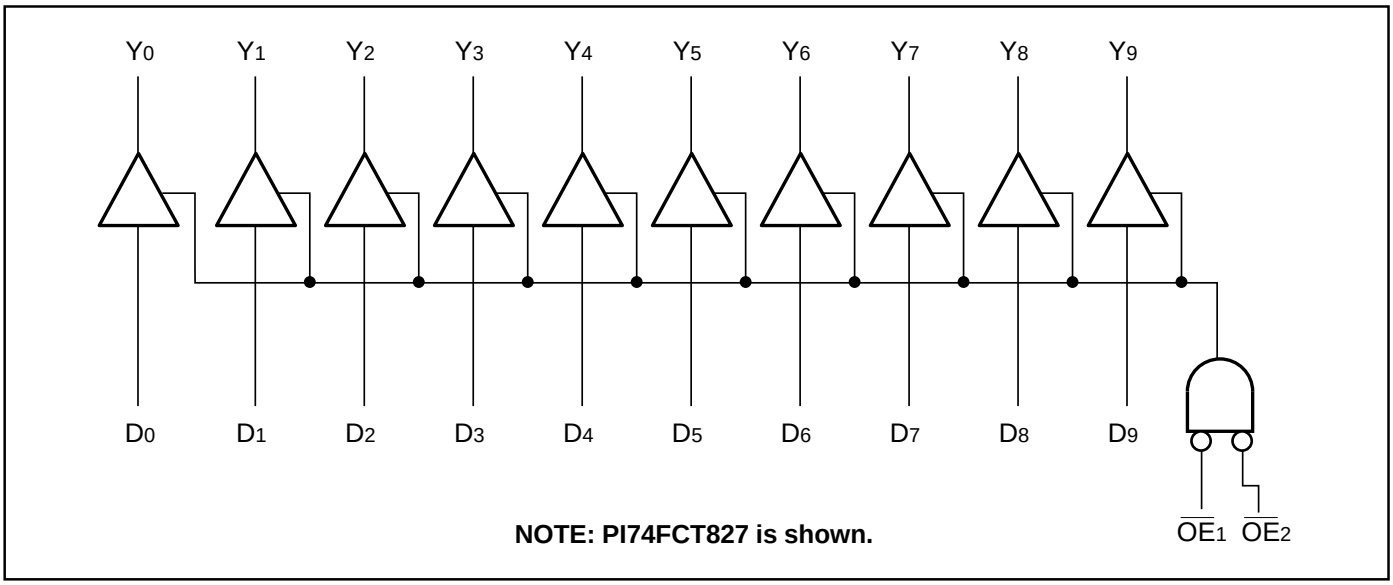
Product Description

Pericom Semiconductor's PI74FCT series of logic circuits are produced in the Company's advanced 0.8 micron CMOS technology, achieving industry leading speed grades. All PI74FCT2XXX devices have a built-in 25-ohm series resistor on all outputs to reduce noise because of reflections, thus eliminating the need for an external terminating resistor.

The PI74FCT827/828T and the PI74FCT2827/2828T are 10-bit wide bus drivers providing high-performance bus interface buffering for wide address/data paths or buses carrying parity. The 10-bit buffers have NAND-ed output enables for maximum control flexibility. They are designed for high-capacitance load drive capability, while providing low-capacitance bus loading at both inputs and outputs. The PI74FCT827/2827T is a non-inverting of the PI74FCT828/2828T.

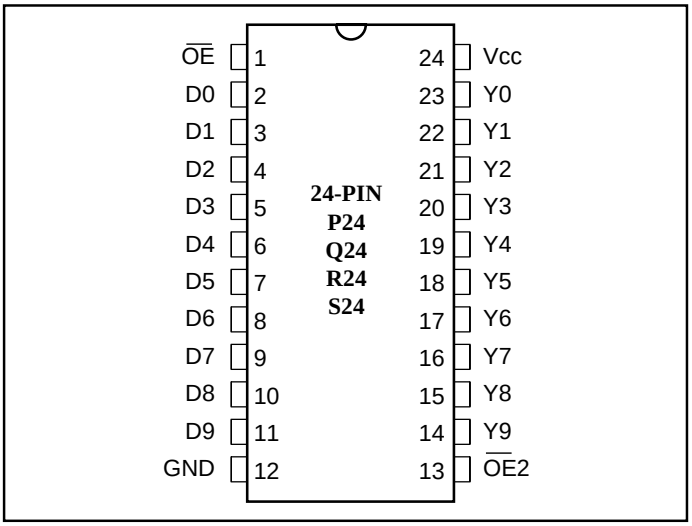
Device models available upon request.

Logic Block Diagram



NOTE: PI74FCT827 is shown.

Product Pin Configuration



Product Pin Description

Pin Name	Description
$\overline{OE}_N$	Output Enable Input (Active LOW)
D0-D9	10-bit Data Inputs
Y0-Y9	10-bit Data Outputs
GND	Ground
V_{CC}	Power

PI74FCT827/2827T Truth Table (Non-Inverting)[1]

	Inputs			Outputs
Function	$\overline{OE}1$	$\overline{OE}2$	D_N	Y_N
Transparent	L	L	L	L
	L	L	H	H
Three-State	H	X	X	Z
	X	H	X	Z

PI74FCT828/2828T Truth Table (Inverting)[1]

	Inputs			Outputs
Function	$\overline{OE}1$	$\overline{OE}2$	D_N	Y_N
Transparent	L	L	L	H
	L	L	H	L
Three-State	H	X	X	Z
	X	H	X	Z

1. H = High Voltage Level
   L = Low Voltage Level
   X = Don't Care
   Z = High Impedance

Maximum Ratings

(Above which the useful life may be impaired. For user guidelines, not tested.)

Storage Temperature	–65°C to +150°C
Ambient Temperature with Power Applied	-40°C to +85°C
Supply Voltage to Ground Potential (Inputs & Vcc Only)	–0.5V to +7.0V
Supply Voltage to Ground Potential (Outputs & D/O Only)	–0.5V to +7.0V
DC Input Voltage	–0.5V to +7.0V
DC Output Current	120mA
Power Dissipation	0.5W

Note:
Stresses greater than those listed under MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

DC Electrical Characteristics (Over the Operating Range, T_A = –40°C to +85°C, V_{CC} = 5.0V ± 5%)

Parameters	Description	Test Conditions[1]		Min.	Typ[2]	Max.	Units
V_{OH}	Output HIGH Voltage	V_{CC} = Min., V_{IN} = V_{IH} or V_{IL}	I_{OH} = –15.0mA	2.4	3.0		V
V_{OL}	Output LOW Current	V_{CC} = Min., V_{IN} = V_{IH} or V_{IL}	I_{OL} = 48mA		0.3	0.50	V
V_{OL}	Output LOW Current	V_{CC} = Min., V_{IN} = V_{IH} or V_{IL}	I_{OL} = 12mA (25Ω Series)		0.3	0.50	V
V_{IH}	Input HIGH Voltage	Guaranteed Logic HIGH Level		2.0			V
V_{IL}	Input LOW Voltage	Guaranteed Logic LOW Level				0.8	V
I_{IH}	Input HIGH Current	V_{CC} = Max.	V_{IN} = V_{CC}			1	µA
I_{IL}	Input LOW Current	V_{CC} = Max.	V_{IN} = GND			–1	µA
I_{OZH}	High Impedance	V_{CC} = Max.	V_{OUT} = 2.7V			1	µA
I_{OZL}	Output Current		V_{OUT} = 0.5V			–1	µA
V_{IK}	Clamp Diode Voltage	V_{CC} = Min., I_{IN} = –18mA			–0.7	–1.2	V
I_{OFF}	Power Down Disable	V_{CC} = GND, V_{OUT} = 4.5V		—	—	100	µA
I_{OS}	Short Circuit Current	V_{CC} = Max.[3], V_{OUT} = GND		–60	–120		mA
V_H	Input Hysteresis				200		mV

Capacitance (T_A = 25°C, f = 1 MHz)

Parameters[4]	Description	Test Conditions	Typ	Max.	Units
C_{IN}	Input Capacitance	V_{IN} = 0V	6	10	pF
C_{OUT}	Output Capacitance	V_{OUT} = 0V	8	12	pF

Notes:
1. For Max. or Min. conditions, use appropriate value specified under Electrical Characteristics for the applicable device type.
2. Typical values are at Vcc = 5.0V, +25°C ambient and maximum loading.
3. Not more than one output should be shorted at one time. Duration of the test should not exceed one second.
4. This parameter is determined by device characterization but is not production tested.

Power Supply Characteristics

Parameters	Description	Test Conditions[1]		Min.	Typ[2]	Max.	Units
I_{CC}	Quiescent Power Supply Current	V_{CC} = Max.	V_{IN} = GND or V_{CC}		0.1	500	µA
ΔI_{CC}	Supply Current per Input @ TTL HIGH	V_{CC} = Max.	V_{IN} = 3.4V[3]		0.5	2.0	mA
I_{CCD}	Supply Current per Input per MHz[4]	V_{CC} = Max., Outputs Open $\overline{OE}1$ = $\overline{OE}2$ = GND One Input Toggling 50% Duty Cycle	V_{IN} = V_{CC} V_{IN} = GND		0.15	0.25	mA/ MHz
I_C	Total Power Supply Current[6]	V_{CC} = Max., Outputs Open f_{CP} = 10 MHz 50% Duty Cycle $\overline{OE}1$ = $\overline{OE}2$ = GND f_I = 5 MHz One Bit Toggling	V_{IN} = V_{CC} V_{IN} = GND		1.5	3.5[5]	mA
			V_{IN} = 3.4V V_{IN} = GND		1.8	4.5[5]	
		V_{CC} = Max., Outputs Open f_{CP} = 10 MHz 50% Duty Cycle $\overline{OE}1$ = $\overline{OE}2$ = GND Eight Bits Toggling f_I = 2.5 MHz 50% Duty Cycle	V_{IN} = V_{CC} V_{IN} = GND		3.0	6.0[5]	
			V_{IN} = 3.4V V_{IN} = GND		5.0	14.0[5]	

Notes:
1. For Max. or Min. conditions, use appropriate value specified under Electrical Characteristics for the applicable device.
2. Typical values are at Vcc = 5.0V, +25°C ambient.
3. Per TTL driven input (V_{IN} = 3.4V); all other inputs at Vcc or GND.
4. This parameter is not directly testable, but is derived for use in Total Power Supply Calculations.
5. Values for these conditions are examples of the Icc formula. These limits are guaranteed but not tested.
6. $I_C = I_{QUIESCENT} + I_{INPUTS} + I_{DYNAMIC}$
   $I_C = I_{CC} + \Delta I_{CC} D_H N_T + I_{CCD} (f_{CP}/2 + f_I N_I)$
   I_{CC} = Quiescent Current
   ΔI_{CC} = Power Supply Current for a TTL High Input (V_{IN} = 3.4V)
   D_H = Duty Cycle for TTL Inputs High
   N_T = Number of TTL Inputs at D_H
   I_{CCD} = Dynamic Current Caused by an Input Transition Pair (HLH or LHL)
   f_{CP} = Clock Frequency for Register Devices (Zero for Non-Register Devices)
   f_I = Input Frequency
   N_I = Number of Inputs at f_I
   All currents are in milliamps and all frequencies are in megahertz.

PI74FCT827/2827T (non-inverting) Switching Characteristics over Operating Range

Parameters	Description	Conditions[1]	827AT/2827AT Com.		827BT/2827BT Com.		827CT/2827CT Com.		827DT Com.		Units
			Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
t_{PLH} t_{PHL}	Propagation Delay D_N to Y_N	C_L = 50pF R_L = 500Ω	1.5	6.5	1.5	5.0	1.5	4.4	1.5	3.8	ns
		C_L = 300pF[3] R_L = 500Ω	1.5	15.0	1.5	13.0	1.5	10.0	1.5	7.5	
t_{PZH} t_{PZL}	Output Enable Time $\overline{OE}_N$ to Y_N	C_L = 50pF R_L = 500Ω	1.5	9.5	1.5	8.0	1.5	7.0	1.5	5.0	
		C_L = 300pF[3] R_L = 500Ω	1.5	23.0	1.5	15.0	1.5	14.0	1.5	9.0	
t_{PHZ} t_{PLZ}	Output Disable Time[3] $\overline{OE}_N$ to Y_N	C_L = 5pF[3] R_L = 500Ω	1.5	8.5	1.5	6.0	1.5	5.7	1.5	4.3	
		C_L = 50pF R_L = 500Ω	1.5	10.0	1.5	7.0	1.5	6.0	1.5	4.3	

PI74FCT828/2828T (inverting) Switching Characteristics over Operating Range

Parameters	Description	Conditions[1]	828AT/2828AT Com.		828BT/2828BT Com.		828CT Com.		Units
			Min.	Max.	Min.	Max.	Min.	Max.	
t_{PLH} t_{PHL}	Propagation Delay D_N to Y_N	C_L = 50 pF R_L = 500Ω	1.5	6.5	1.5	5.5	1.5	4.4	ns
		C_L = 300 pF[3] R_L = 500Ω	1.5	15.0	1.5	13.0	1.5	10.0	ns
t_{PZH} t_{PZL}	Output Enable Time $\overline{OE}_N$ to Y_N	C_L = 50 pF R_L = 500Ω	1.5	9.5	1.5	8.0	1.5	7.0	ns
		C_L = 300 pF[3] R_L = 500Ω	1.5	23.0	1.5	15.0	1.5	14.0	ns
t_{PHZ} t_{PLZ}	Output Disable Time[3] $\overline{OE}_N$ to Y_N	C_L = 5 pF[3] R_L = 500Ω	1.5	8.5	1.5	6.0	1.5	5.7	ns
		C_L = 50 pF R_L = 500Ω	1.5	10.0	1.5	7.0	1.5	6.0	ns

Notes:
1. See test circuit and waveforms.
2. Minimum limits are guaranteed but not tested on Propagation Delays.
3. This parameter is guaranteed but not production tested.